Dislocation Structure and Crystallite Size Distribution in Plastically Deformed Metals Determined by Diffraction Peak Profile Analysis

The dislocation densities and arrangement parameters and the crystallite size and size-distributions are determined in tensile or cyclically deformed polycrystalline copper specimens by X-ray diffraction peak profile analysis. The Fourier coefficients of profiles measured by a special high resolution X-ray diffractometer with negligible instrumental broadening have been fitted by the Fourier transforms of ab-initio size and strain profiles. It is found that in the fatigued samples the dislocations are mainly of edge type with strong dipole character. In the fatigued specimens the dislocation densities are found to be larger than in the tensile deformed samples when the saturation and flow stress levels are the same. [DOI: 10.1115/1.1418364]

1 Introduction

Dislocation structures are directly observed in micrographs obtained by transmission electron microscopy (TEM). These observations provide details on the micron scale. Comprehensive studies of the dislocation structures in plastically deformed metals have been carried out by different groups [1-3]. The average properties of the dislocation structures on the hundreds of microns up to millimeters scale, especially, some properties like long range internal stresses [4-7], dislocation densities [8-10], arrangement parameters [11,12] or statistical fluctuations [13-15] are better obtained by diffraction peak profile analysis [16].

Diffraction peaks broaden when crystallites are small or the material contains lattice defects. The diffraction order dependence of two effects is different enabling their separation. The two classical methods for this are: (i) the Williamson-Hall [17] and (ii) the Warren-Averbach [18] procedures. The first is based on the Full Widths at Half Maximum (FWHM) and the integral breadths while the second on the Fourier coefficients of the profiles. Both methods provide, in principle, apparent size parameters of crystallites or coherently diffracting domains and values of the mean square strain. The evaluations become, however, complicated if either the crystallite shape [19] or strain [20] are anisotropic. The mean square strain is often attempted to be given as a single valued quantity [18,21]. Experiment has shown, however, that the mean square strain, \( \langle e^2 \rangle \), is never a constant, neither as a function of \( L \) nor \( g \), where \( L \) and \( g \) are the Fourier length (see below) and the absolute value of the diffraction vector, respectively [5-10,18,22-27]. The g dependence is further complicated by strain anisotropy which means that neither the breadth nor the Fourier coefficients of the diffraction profiles are monotonous functions of the diffraction angle or g [20,24,25,28-31].

In order to separate strain and size correctly strain anisotropy has to be treated properly. Two different models have been developed so far to this aim: (i) the phenomenological model based on the elastic anisotropy of crystals [30] and (ii) the dislocation model [24] based on the mean square strain of dislocated crystals [9,11,12]. Latter takes into account that the effect of dislocations on strain broadening depends on the relative orientations of the line and Burgers vectors of dislocations and the diffraction vector, similarly as the contrast effect of dislocations in electron microscopy. Anisotropic contrast can be summarized in contrast factors, \( C \), which can be calculated numerically on the basis of the crystallography of dislocations and the elastic constants of the crystal [9,11,12,22,24,31-33]. Using the average contrast factors the modified Williamson-Hall and the modified Warren-Averbach procedures have been suggested [24], enabling to determine (i) different averages of crystallite sizes, (ii) the density and (iii) the effective outer cut off radius of dislocations [24,34]. A method has recently been developed to determine (a) crystallite size distribution and the dislocation structure in terms of (b) density, (c) arrangement parameter, and (d) character of dislocations [34].

In the present work, diffraction peak profile analysis is outlined briefly and applied to characterize the differences and/or similarities in the crystallite size distribution and in the average dislocation structure in copper specimens either in tension or in fatigue.

2 Evaluation of Broadened Diffraction Peak Profiles

2.1 The Modified Warren-Averbach (mWA) Equation.

According to the kinematical theory of diffraction the physical profiles of Bragg reflections are the convolution of the size and strain profiles [35]:

\[
I = I_s + I_d, \tag{1}
\]

where the superscripts \( F, S, \) and \( D \) refer to physical, size, and strain (distortion), respectively, \( (physical \ \text{profile} \ \text{here means} \ \text{either} \ \text{that the measured profiles have been corrected for instrumental effects or that the instrumental effects are negligible}) \). The discrete Fourier transform of Eq. (1) is the Warren-Averbach equation [18]:

\[
A_L = A^P_L A^S_L A^D_L = A^P_L \exp\left(-2\pi^2 L^2 g^2 \langle e^2 \rangle \right), \tag{2}
\]

where \( L \) is the Fourier variable; \( L = n \alpha \), \( n \) are integers and \( \alpha \) is the unit of the Fourier length in the direction of the diffraction vector \( g \); \( \alpha = \lambda / \left(2 (\sin \theta_1 - \sin \theta_2)\right) \), the diffraction profile is mea-
The size-distribution of crystallites can be determined by the modified Williamson-Hall and Warren-Averbach procedures. From the FWHM, the integral breadth and the Fourier transform of the measured profiles yield three apparent size parameters by the evaluation of Eqs. (5) and (7): $D$, $D'$ and $L_0$. On the other hand, the FWHM, the integral breadth and the Fourier transform of the size profile in Eq. (11), $I^2(q)$, provide numerically calculated values for the three apparent size parameters: $D^{app}$, $D'^{app}$ and $L_0^{app}$, each of which depend on $m$ and $\sigma$. The calculated and the measured apparent size parameters can be matched by the least squares method in order to obtain the $m$ and $\sigma$ parameter values corresponding to the experimentally determined apparent size values:

\[(D^{app} - D)^2 + (F^{app} - F) + (L_0^{app} - L_0)^2\] = minimum, (12)

in which the fitting is carried out for $m$ and $\sigma$. For spherical crystallites with log-normal size distribution the area-, volume- and arithmetically-weighted mean crystallite sizes are [37]:

\[(x)^{area} = m \exp(2.5\sigma^2), \quad (x)^{vol} = m \exp(3.5\sigma^2), \quad (x)^{arith} = m \exp(0.5\sigma^2).\] (13)

This simple and pragmatic procedure is believed to be more reliable than the methods in which either only the Fourier transform of profiles is used [38] or in which only two parameters of the profiles, e.g., the integral breadths and the Fourier transform are used.

2.5.2 The Dislocation Parameters Determined by the Modified Williamson-Hall and Warren-Averbach Procedures. From the modified Warren-Averbach equation in (5) and the modified Williamson-Hall plot in Eq. (7) the $q$ parameter of the dislocation contrast factors, as defined in Eq. (6), can be determined. If the elastic constants of the material are known the experimental values of the $q$ parameter enables the determination of the character of dislocations. In cubic crystals, for example, in terms of the volume fraction of screw or edge dislocations. The uncertainty in the determination of the value of the $q$ parameter can be considerable thus the conclusions about the dislocation character have to be treated critically with respect to the experimental errors. The density and the arrangement parameter of dislocations, $\rho$ and $M$, where $M = R_c N_c$, can be determined from Eq. (5). The coefficients of the second term in the equation provide $p R_c L_0$, as a function of $L$. Plotting these values versus $L$ for small $L$ values enables the graphical determination of $\rho$ and $R_c$ [39].

2.5.3 The Crystallite-Size and the Dislocation Parameters Determined by the Method of Multiple Whole Profile (MWP) Fitting [34,40]. The Wilkens function in Eq. (3), $f(\eta)$, together with the Fourier coefficients of the size profile in Eq. (11) enable the fitting of either the Fourier coefficients of the physical profiles in the entire range of $L$ or the whole physical profiles themselves. The details of the Wilkens function can be found in the equations A6.5 to A6.8 in [12] and are reproduced [34,40]. A theoretical procedure [34] and the corresponding software [40] have been developed to fit the Fourier transforms of the experimentally determined physical peak-profiles by the product of the Fourier transforms of the size profile in Eq. (11) and the strain profile given by $A_{\tilde{c}}^n$, $\langle \tilde{c} \rangle_{\tilde{c}}$ and $f(\eta)$ in Eqs. (2) and (3). The procedure...
can alternatively be used to fit the intensity distributions of measured profiles themselves. The Fourier transform of the size profile has been calculated in explicit form for spherical or ellipsoidal crystallite shape assuming log-normal size distribution [34,40]. Strain anisotropy is accounted for by scaling the strain profiles by $K^2C$. The only fitting parameters in this procedure are the following microstructural quantities: (i) $m$ and (ii) $\sigma$ for the log-normal crystallite size distribution function, (iii) $p$ and (iv) $M$, for the density and the arrangement parameter of dislocations, and (v) $q$ for the average dislocation contrast factors in cubic crystals, respectively.

3 Experimental

3.1 Samples. Two pairs of four-nine (99.99 percent purity) OFHC polycrystalline copper specimens were deformed either by tension or cyclically to the same flow stress or saturation stress values of about 80 and 160 MPa, respectively. The stress and strain values are listed in the Table 1. The cyclic experiments were carried up to 2000 cycles, saturation was reached after the first few tens of cycles. It is assumed that in the fatigued samples a well developed cell structure with relatively narrow dislocation cell walls are developed [41]. The gauge length and diameter of the specimens was 16 and 6 mm, respectively. For the X-ray measurements cylinders of 4 mm height from the uniformly deformed regions were prepared. The measurements were performed on carefully polished and chemically etched surfaces perpendicular to the stress axis.

3.2 X-Ray Diffraction Technique. The diffraction profiles were measured by a special double crystal diffractometer with negligible instrumental broadening. A long fine focus copper anode of a sealed X-ray tube (Philips) was operated as a line focus at 40 kV and 25 mA. The symmetrical 220 reflection of a Ge plane monochromator was producing a parallel beam of about 100 $\mu$m thick foot print on the specimen. The $K_{\alpha 2}$ component of the Cu radiation was eliminated by an 16 $\mu$m slit between the source and the Ge crystal. The profiles were registered by a linear position sensitive gas flow detector, OED 50 Braun, Munich. In order to avoid air scattering and absorption the distance between the specimen and the detector was overbridged by an evacuated tube closed by mylar windows. The distance between the specimen and the detector was set either at 500 or 300 mm depending on the width of the measured profiles.

4 Results and Discussion

In the present work, the measured profiles are evaluated by the Multiple Whole Profile (MWP) fitting procedure described in section 2.5.3. The measured and fitted Fourier coefficients and intensity distributions for the specimen tensile deformed to the flow stress and strain $\varepsilon_{\text{flow}}=82$ MPa and $\varepsilon=0.045$, respectively (Tensile 1, in Table 1) are shown in Fig. 1. The differences between the measured and fitted values are also shown in the lower parts of the figure. In Fig. 1(b) it can be seen that, though the differences between the measured a fitted intensities (in the lower part of the figure) are satisfactorily small, they have somewhat larger values for the 311 and 400 reflections. This has the following reason. Already at this strain level, $\varepsilon=0.045$, the dislocations are distributed heterogeneously. According to the composite model, in such dislocation structures long range internal stresses develop which are strongest in the (100) directions [4,41]. These long range internal stresses are manifested by pronounced asymmetries of the 200 and 311 diffraction profiles, especially in copper [5]. Here we note that the same effect is somewhat stronger in the specimen deformed to $\varepsilon=0.166$. The fitting procedure is carried out using the absolute values of the Fourier coefficients of the measured profiles and the fitted Fourier coefficients are all real. Obviously,

<table>
<thead>
<tr>
<th>Specimen</th>
<th>$\sigma_{\text{mesh}}$ [MPa]</th>
<th>$\varepsilon$: $\Delta\varepsilon_{\text{pl}}$ [10$^{-6}$ m$^{-2}$]</th>
<th>$\rho$ [10$^{-14}$ m$^{-2}$]</th>
<th>$M$</th>
<th>$q$</th>
<th>$n_v$ [nm]</th>
<th>$\sigma$</th>
<th>$\langle\chi\rangle_{\text{vol}}$ [nm]</th>
</tr>
</thead>
<tbody>
<tr>
<td>Tensile 1</td>
<td>82</td>
<td>0.045</td>
<td>0.3</td>
<td>2.1</td>
<td>1.8</td>
<td>0.01</td>
<td>316</td>
<td>0.21</td>
</tr>
<tr>
<td>Tensile 2</td>
<td>164</td>
<td>0.166</td>
<td>3.6</td>
<td>1.5</td>
<td>1.93</td>
<td>0.1</td>
<td>129</td>
<td>0.20</td>
</tr>
<tr>
<td>Fatigue 1</td>
<td>82</td>
<td>2.5x10$^{-3}$</td>
<td>3.9</td>
<td>0.32</td>
<td>1.67</td>
<td>0.1</td>
<td>123</td>
<td>0.26</td>
</tr>
<tr>
<td>Fatigue 2</td>
<td>164</td>
<td>5x10$^{-3}$</td>
<td>5.8</td>
<td>0.33</td>
<td>1.67</td>
<td>0.1</td>
<td>129</td>
<td>0.38</td>
</tr>
</tbody>
</table>

Fig. 1 (a) The measured (open circles) and the fitted theoretical (solid line) Fourier coefficients as a function of the Fourier variable $L$ for the specimen deformed by tension to 82 MPa. The differences between the measured and fitted values are also shown in the lower part of the figure. The indices of the reflections are also indicated. (b) The measured intensity profiles (open circles) and the inverse Fourier transform of the fitted Fourier coefficients (solid lines) for the specimen deformed by tension to 82 MPa. The differences between the measured and fitted intensity values are also shown in the lower parts of the linear scale plots.
the inverse Fourier transform of the fitted Fourier coefficients will be a symmetric profile deviating most from the measured profiles when the asymmetry is strongest, i.e., in the case of the 311 and 400 reflections.

The values of \( p, M, q, m, \) and \( \sigma \) obtained directly from the fitting procedure are listed in the Table 1. The volume average crystallite size, \( (x)_{av} \), as defined in Eq. (136) is also given in the table. The following conclusions can be drawn from the data. (i) The dislocation densities in the fatigued specimens are larger than in the tensile deformed ones when the flow stress is equal to the saturation stress. (ii) The dislocation arrangement parameter values, \( M \), are considerably larger in the tensile deformed than in the fatigued states. (iii) The \( q \) parameter values are about 1.9 and 1.67 in the tensile deformed and in the fatigued states, respectively. (iv) The volume averaged crystallite size values decrease during deformation.

Taking into account that in the fatigued state the dislocation cell structure is well developed in which the thin cell walls have a volume fraction of about 0.1 [4] the local dislocation density in the cell walls of these samples is about 4 - 5 \( 10^{15} \text{m}^{-2} \). In the tensile deformed specimens the cell walls are woolly, irregular and thick and have a volume fraction of about 0.25 to 0.4 [42]. This means that in these samples the local dislocation density in the cell walls is about 0.1 - 1 \( 10^{15} \text{m}^{-2} \). The local dislocation density in the cell walls of the fatigued samples is by about a factor of 5 to 50 larger than in the tensile deformed specimens. This is in good correlation with both, the \( M \) and \( q \) parameter values. The value of \( M \) gives the strength of the dipole character of dislocations [11,12]: If \( M \) is small or large the dipole character and the screening of the displacements field of dislocations is strong or weak, respectively. At the same time, strong or weak screening and small or large values of \( M \) means strong or weak correlations in the dislocation distributions. The large and small values of \( M \) for the tensile deformed and fatigued samples means that in the fatigued samples the dipole character of dislocations is considerably stronger and the screening of displacement fields is much more effective than in the tensile deformed specimens. The possible \( q \) values were calculated numerically in [33] for Burgers vectors: \( b = a/2(110) \) for fcc crystals as a function of the elastic anisotropy, \( A = 2A_{44} / (c_{44} - c_{11}) \), where \( c_{ij} \) are the elastic constants of the crystal. The \( q \) parameter values are distinctly different for edge or screw dislocations at a particular value of the Zener constant, \( A_{i} \), as it can be seen from the figures in [33]. For copper \( A_{i} = 3.21 \) and the \( q \) parameter values are 1.68 and 2.37 for pure edge and pure screw dislocations, respectively. The \( q = 1.9 \) value for the tensile deformed samples means that the dislocations are of mixed character. The \( q = 1.6 - 1.7 \) values for the fatigued samples mean that the dislocations are mainly of edge character.

Both, (a) the stronger dipole and mainly edge character of dislocations in the fatigued samples and (b) the weak dipole and mixed character of dislocations in the tensile deformed samples are in good correlation with other observations, especially TEM experiments [1-4,42].

On the basis of the \( m \) and \( \sigma \) values in Table 1 and Eq. (10) the crystallite size distribution functions, \( f(x) \), are drawn in Fig. 2. It can be seen that after a few percent tensile deformation (Tensile 1 specimen) the size distribution is at large \( x \) values and is broad. After about 17 percent deformation \( f(x) \) shifts to lower \( x \) values and becomes somewhat narrower. The two fatigued samples reveal similar size distributions. The volume averaged crystallite size is about 400 nm in the sample tensile deformed to a few percent and this value decreases to about 200 nm in the samples deformed either in tension to 17 percent or in fatigue to \( \Delta \sigma_{f} = 2.5 - 5 \times 10^{3} \). The average size of dislocation cells varies from one to a few microns in copper specimens deformed in these deformation regimes [1-4]. This apparent discrepancy between the average crystallite size obtained from peak broadening or observed in TEM micrographs has the following reasons. In a bulk specimen, like the copper samples investigated here, there is a hierarchy of length scales [1,3]. In decreasing order they are: (i) grains, (ii) cell blocks, (iii) subgrains, (iv) dislocation cells, (v) cell interiors, (vi) cell boundaries, and (vii) distances between dislocations. (Note that, this hierarchy becomes more complicated for bulk materials with different phase, e.g., in alloys containing precipitates or in composites.) The misorientation between the different units of the microstructure can vary from zero through small angles to large angles. Crystallite size in X-ray diffraction is equivalent with the domains which are separated from the surrounding by a small misorientation, typically one or two degrees. The largest units in the microstructure are the grains where the adjacent units are separated by large angles. All other units from cell block down to cell boundaries can have very different misorientations ranging from a few tenths of degrees to any large value. The scales of misorientations within grains depends basically on the dislocation structure and arrangement inside the grains. Dipoles cause no misorientations, however, a few dislocations aligned in the configuration of small angle grain boundaries, can produce misorientations of a few degrees. Due to this type of misorientation the scattering coherency of X-rays or neutrons can break down producing crystallite size values smaller than the grain size or even subgrain size observed in a TEM micrograph. A comparison of the average dislocation distances and the crystallite size obtained from the scattering experiment can tell to what extent the dislocations are arranged in dipoles or in arrangements producing misorientations.

Conclusions

A recently developed method of diffraction peak profile analysis has been applied to investigate the difference of the dislocation structure in tensile deformed and fatigued copper specimens and the following conclusions can be made.

1. The dislocation densities in the fatigued specimens are found to be larger than in the tensile deformed ones when the flow stress is equal to the saturation stress in good correlation with TEM observations in the literature.
2. The dislocation arrangement parameter values, \( M \), are considerably larger in the tensile deformed than in the fatigued states indicating that in the fatigued samples the dislocations are arranged with more dipole character.
3. Strain anisotropy of peak broadening provided \( q \) parameter values of the dislocation contrast factors which are about 1.9 and 1.67 in the tensile deformed and in the fatigued states, corresponding to mixed and mainly edge dislocation character in the two different deformation modes, respectively.
4. Crystallite size and size-distributions have been determined and discussed in terms of dislocation caused misorientations and TEM observations.
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References


